

<b>Notice of References Cited</b>	Applicant/Patent Yamahara	Application/Control No. <b>08/997,219</b>
	Examiner Kenneth Parker	Art Unit <b>2871</b>

**U.S. PATENT DOCUMENTS**

	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Name</b>	<b>Classification</b> <sup>2</sup>	
A	5,760,859	6/1998	Bosma et al	349	75
B	5,559,618	9/1996	Mori et al	349	117
C					
D					
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F					
G					
H					
I					
J					
K					
L					
M					

**FOREIGN PATENT DOCUMENTS**

	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Country</b>	<b>Name</b>	<b>Classification</b> <sup>2</sup>
N					
O					
P					
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R					
S					
T					

**NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages	
U	Herke, "LCD Modeling aids a display Characterization Tool", SID 1995	
V	Wu, "Phase -Matched Compensation Films for Liquid Crystal Displays", Materials, Chemicals and Physics, 42 (1995) 163-168	
W		
X		

\* A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).

<sup>1</sup> Dates in MM-YYYY format are publication dates.

<sup>2</sup> Classifications may be U.S. or foreign.